

# DS91M125 125 MHz 1:4 M-LVDS Repeater with LVDS Input

Check for Samples: DS91M125

### **FEATURES**

- DC 125 MHz / 250 Mbps Low Jitter, Low Skew, Low Power Operation
- **Independent Driver Enable Pins**
- **Outputs Conform to TIA/EIA-899 M-LVDS Standard**
- **Controlled Transition Times Minimize** Reflections
- Inputs Conform to TIA/EIA-644-A LVDS Standard
- 8 kV ESD on M-LVDS Output Pins Protects Adjoining Components
- Flow-Through Pinout Simplifies PCB Layout
- **Industrial Operating Temperature Range** (-40°C to +85°C)
- Available in a Space Saving SOIC-16 Package

#### **APPLICATIONS**

- **Multidrop / Multipoint Clock and Data** Distribution
- High-Speed, Low Power, Short-Reach Alternative to TIA/EIA-485/422
- Clock Distribution in AdvancedTCA (ATCA) and MicroTCA (µTCA, uTCA) Backplanes

#### DESCRIPTION

The DS91M125 is a 1:4 M-LVDS repeater designed for driving and distributing clock or data signals to up to four multipoint networks.

M-LVDS (Multipoint LVDS) is a new family of bus interface devices based on LVDS technology specifically designed for multipoint and multidrop cable and backplane applications. It differs from standard LVDS in providing increased drive current to handle double terminations that are required in multiapplications. Controlled transition point minimize reflections that are common in multipoint configurations due to unterminated stubs.

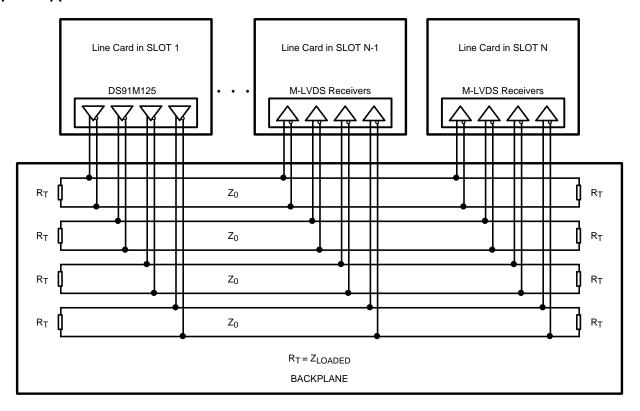
A single DS91M125 channel is a 1:4 repeater that accepts M-LVDS/LVDS/CML/LVPECL signals and converts them to M-LVDS signal levels. Each output has an associated independent driver enable pin. The DS91M125 input conforms to the LVDS standard.

The DS91M125 has a flow-through pinout for easy PCB layout. It provides a new alternative for high speed multipoint interface applications. It is packaged in a space saving SOIC-16 package.

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# **Typical Application**



# **Connection Diagram**

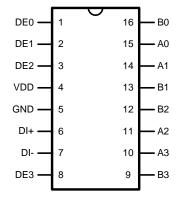
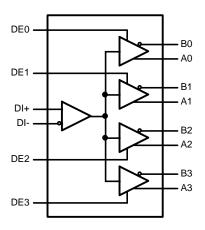


Figure 1. 16-Lead (0.150" Wide) Molded Small Outline Package, JEDEC See Package Number D0016A



# **Logic Diagram**



### **PIN DESCRIPTIONS**

	2201111110110											
Number	Name	I/O, Type	Description									
1, 2, 3, 8	DE	I, LVCMOS	Driver enable pins: When DE is low, the driver is disabled. When DE is high, the driver is enabled. There is a 300 k $\Omega$ pulldown resistor on each pin.									
6	DI+	I, LVDS	Non-inverting receiver input pin.									
7	DI-	I, LVDS	Inverting receiver input pin.									
5	GND	Power	Ground pin.									
10, 11, 14, 15	Α	O, M-LVDS	Non-inverting driver output pin.									
9, 12, 13, 16	В	O, M-LVDS	Inverting driver output pin.									
4	$V_{DD}$	Power	Power supply pin, +3.3V ± 0.3V									





These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

Absolute Maximum Ratings (1)(2)

Aboolate maximum Ratingo		
Supply Voltage		-0.3V to +4V
LVCMOS Input Voltages		-0.3V to (V <sub>DD</sub> + 0.3V)
M-LVDS Output Voltages	-1.9V to +5.5V	
LVDS Input Voltages		-0.3V to (V <sub>DD</sub> + 0.3V)
Maximum Package Power Dissipation at +25°C	SOIC Package	2.21W
	Derate SOIC Package	19.2 mW/°C above +25°C
Thermal Resistance (4-Layer, 2 oz. Cu, JEDEC)	$\theta_{JA}$	52°C/W
	$\theta_{JC}$	19°C/W
Maximum Junction Temperature		140°C
Storage Temperature Range		−65°C to +150°C
Lead Temperature (Soldering, 4 seconds)		260°C
ESD Susceptibility	HBM <sup>(3)</sup>	≥ 8 kV
	MM <sup>(4)</sup>	≥ 250V
	CDM <sup>(5)</sup>	≥ 1250V

- Absolute Maximum Ratings indicate limits beyond which damage to the device may occur, including inoperability and degradation of device reliability and/or performance. Functional operation of the device and/or non-degradation at the Absolute Maximum Ratings or other conditions beyond those indicated in the Recommended Operating Conditions is not implied. The Recommended Operating Conditions indicate conditions at which the device is functional and the device should not be operated beyond such conditions.
- If Military/Aerospace specified devices are required, please contact the TI Sales Office/ Distributors for availability and specifications.
- Human Body Model, applicable std. JESD22-A114C Machine Model, applicable std. JESD22-A115-A
- Field Induced Charge Device Model, applicable std. JESD22-C101-C

# **Recommended Operating Conditions**

	Min	Тур	Max	Units
Supply Voltage, V <sub>DD</sub>	3.0	3.3	3.6	V
Voltage at M-LVDS Outputs	-1.4		+3.8	V
Voltage at LVDS Inputs	0		$V_{DD}$	V
LVCMOS Input Voltage High V <sub>IH</sub>	2.0		$V_{DD}$	V
LVCMOS Input Voltage Low V <sub>IL</sub>	0		0.8	V
Operating Free Air Temperature T <sub>A</sub>	-40	+25	+85	°C



### **Electrical Characteristics**

Over recommended operating supply and temperature ranges unless otherwise specified. (1)(2)(3)(4)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
LVCMOS D	OC Specifications		'		'	
V <sub>IH</sub>	High-Level Input Voltage		2.0		$V_{DD}$	V
V <sub>IL</sub>	Low-Level Input Voltage		GND		0.8	V
I <sub>IH</sub>	High-Level Input Current	V <sub>IH</sub> = 3.6V	-15	±1	15	μΑ
I <sub>IL</sub>	Low-Level Input Current	V <sub>IL</sub> = 0V	-15	±1	15	μA
V <sub>CL</sub>	Input Clamp Voltage	I <sub>IN</sub> = -18 mA	-1.5			V
M-LVDS D	river DC Specifications					
V <sub>AB</sub>	Differential output voltage magnitude	$R_L = 50\Omega$ , $C_L = 5pF$	480		650	mV
$\Delta V_{AB}$	Change in differential output voltage magnitude between logic states	See Figure 2and Figure 4	-50	0	+50	mV
V <sub>OS(SS)</sub>	Steady-state common-mode output voltage	$R_L = 50\Omega$ , $C_L = 5pF$	0.3	1.6	2.1	V
$ \Delta V_{OS(SS)} $	Change in steady-state common-mode output voltage between logic states	See Figure 2 and Figure 3	0		+50	mV
V <sub>A(OC)</sub>	Maximum steady-state open-circuit output voltage	See Figure 5	0		2.4	V
V <sub>B(OC)</sub>	Maximum steady-state open-circuit output voltage		0		2.4	V
$V_{P(H)}$	Voltage overshoot, low-to-high level output	$R_L = 50\Omega$ , $C_L = 5pF$ , $C_D = 0.5pF$ See Figure 7 and Figure 8			1.2V <sub>SS</sub>	V
V <sub>P(L)</sub>	Voltage overshoot, high-to-low level output		-0.2V			V
I <sub>OS</sub>	Differential short-circuit output current	See Figure 6 (6)	-43		43	mA
I <sub>A</sub>	Driver output current	$V_A = 3.8V, V_B = 1.2V$			32	μA
		$V_A = 0V \text{ or } 2.4V, V_B = 1.2V$	-20		+20	μΑ
		$V_A = -1.4V, V_B = 1.2V$	-32			μA
I <sub>B</sub>	Driver output current	V <sub>B</sub> = 3.8V, V <sub>A</sub> = 1.2V			32	μA
		$V_B = 0V \text{ or } 2.4V, V_A = 1.2V$	-20		+20	μΑ
		$V_B = -1.4V, V_A = 1.2V$	-32			μΑ
I <sub>AB</sub>	Driver output differential current (I <sub>A</sub> - I <sub>B</sub> )	$V_A = V_B, -1.4V \le V \le 3.8V$	-4		+4	μΑ
I <sub>A(OFF)</sub>	Driver output power-off current	$V_A = 3.8V, V_B = 1.2V, \\ DE = 0V \\ 0V \le V_{DD} \le 1.5V$			32	μA
		$V_A = 0V \text{ or } 2.4V, V_B = 1.2V, \\ DE = 0V \\ 0V \le V_{DD} \le 1.5V$	-20		+20	μA
		$V_A = -1.4V, V_B = 1.2V,$ $DE = 0V$ $0V \le V_{DD} \le 1.5V$	-32			μA

<sup>(1)</sup> The Electrical Characteristics tables list ensured specifications under the listed Recommended Operating Conditions except as otherwise modified or specified by the Electrical Characteristics Conditions and/or Notes. Typical specifications are estimations only and are not ensured.

<sup>(2)</sup> Current into device pins is defined as positive. Current out of device pins is defined as negative. All voltages are referenced to ground

except  $V_{OD}$  and  $\Delta V_{OD}$ . (3) Typical values represent most likely parametric norms for  $V_{DD} = +3.3V$  and  $T_A = +25^{\circ}C$ , and at the Recommended Operation Conditions at the time of product characterization and are not ensured.

<sup>(4)</sup>  $C_L$  includes fixture capacitance and  $C_D$  includes probe capacitance.

Specification is ensured by characterization and is not tested in production.

Output short circuit current (IOS) is specified as magnitude only, minus sign indicates direction only.



# **Electrical Characteristics (continued)**

Over recommended operating supply and temperature ranges unless otherwise specified. (1)(2)(3)(4)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
I <sub>B(OFF)</sub>	Driver output power-off current	$V_B = 3.8V, V_A = 1.2V,$ DE = 0V $0V \le V_{DD} \le 1.5V$			32	μA
		$V_B = 0V$ or 2.4V, $V_A = 1.2V$ , DE = 0V $0V \le V_{DD} \le 1.5V$	-20		+20	μA
		$V_B = -1.4V, V_A = 1.2V, \\ DE = 0V \\ 0V \le V_{DD} \le 1.5V$	-32			μA
I <sub>AB(OFF)</sub>	Driver output power-off differential current ( $I_{A(OFF)} - I_{B(OFF)}$ )	$V_A = V_B$ , $-1.4V \le V \le 3.8V$ , DE = 0V $0V \le V_{DD} \le 1.5V$	-4		+4	μA
C <sub>A</sub>	Driver output capacitance	V <sub>DD</sub> = OPEN		7.8		pF
C <sub>B</sub>	Driver output capacitance			7.8		pF
C <sub>AB</sub>	Driver output differential capacitance			3		pF
C <sub>A/B</sub>	Driver output capacitance balance (C <sub>A</sub> /C <sub>B</sub> )			1		
LVDS Rec	eiver DC Specifications					
V <sub>IT+</sub>	Positive-going differential input voltage threshold			-5	100	mV
V <sub>IT</sub> -	Negative-going differential input voltage threshold		-100	-5		mV
$V_{\text{CMR}}$	Common mode voltage range	VID = 100 mV	0.05		V <sub>DD</sub> - 0.05	V
I <sub>IN</sub>	Input current	VIN = 3.6V, V <sub>DD</sub> = 3.6V		±1	±10	μΑ
		VIN = 0V, V <sub>DD</sub> = 3.6V		±1	±10	μΑ
C <sub>IN</sub>	Input capacitance	V <sub>DD</sub> = OPEN		5		pF
POWER S	UPPLY CURRENT					
I <sub>CCD</sub>	Driver Supply Current	$R_L = 50\Omega$ , $DE = V_{DD}$		67	78	mA
I <sub>CCZ</sub>	TRI-STATE Supply Current	DE = GND		21	26	mA



# **Switching Characteristics**

Over recommended operating supply and temperature ranges unless otherwise specified. (1) (2) (3)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
DRIVER AC S	PECIFICATION		<u> </u>			
t <sub>PLH</sub>	Differential Propagation Delay Low to High	$R_L = 50\Omega, C_L = 5 pF,$	3.0	5.5	8.5	ns
t <sub>PHL</sub>	Differential Propagation Delay High to Low	$C_D = 0.5 \text{ pF}$	3.0	5.5	8.5	ns
$t_{SKD1} (t_{sk(p)})$	Pulse Skew  t <sub>PLHD</sub> - t <sub>PHLD</sub>   (4)(5)	See Figure 7 and Figure 8		65	350	ps
t <sub>SKD2</sub>	Channel-to-Channel Skew <sup>(6)(5)</sup>			65	400	ps
t <sub>SKD3</sub>	Part-to-Part Skew <sup>(7)(5)</sup>			2.2	2.5	ns
t <sub>SKD4</sub>	Part-to-Part Skew <sup>(8)</sup>				5.5	ns
t <sub>TLH</sub> (t <sub>r</sub> )	Rise Time <sup>(5)</sup>		1.1	2.0	3.0	ns
t <sub>THL</sub> (t <sub>f</sub> )	Fall Time <sup>(5)</sup>		1.1	2.0	3.0	ns
t <sub>PZH</sub>	Enable Time (Z to Active High)	$R_L = 50\Omega, C_L = 5 pF,$		6	11	ns
t <sub>PZL</sub>	Enable Time (Z to Active Low)	$C_D = 0.5 \text{ pF}$		6	11	ns
t <sub>PLZ</sub>	Disable Time (Active Low to Z)	See Figure 9 and Figure 10		6	11	ns
t <sub>PHZ</sub>	Disable Time (Active High to Z)			6	11	ns
f <sub>MAX</sub>	Maximum Operating Frequency <sup>(5)</sup>		125			MHz

- (1) The Electrical Characteristics tables list ensured specifications under the listed Recommended Operating Conditions except as otherwise modified or specified by the Electrical Characteristics Conditions and/or Notes.
- (2) Typical values represent most likely parametric norms for V<sub>DD</sub> = +3.3V and T<sub>A</sub> = +25°C, and at the Recommended Operation Conditions at the time of product characterization and are not ensured.
- (3) C<sub>L</sub> includes fixture capacitance and C<sub>D</sub> includes probe capacitance.
- (4) t<sub>SKD1</sub>, |t<sub>PLHD</sub> t<sub>PHLD</sub>|, is the magnitude difference in differential propagation delay time between the positive going edge and the negative going edge of the same channel.
- (5) Specification is ensured by characterization and is not tested in production.
- (6) t<sub>SKD2</sub>, Channel-to-Channel Skew, is the difference in propagation delay (t<sub>PLHD</sub> or t<sub>PHLD</sub>) among all output channels.
- (7) t<sub>SKD3</sub>, Part-to-Part Skew, is defined as the difference between the minimum and maximum specified differential propagation delays. This specification applies to devices at the same V<sub>DD</sub> and within 5°C of each other within the operating temperature range.
- (8) t<sub>SKD4</sub>, Part-to-Part Skew, is the differential channel-to-channel skew of any event between devices. This specification applies to devices over recommended operating temperature and voltage ranges, and across process distribution. t<sub>SKD4</sub> is defined as |Max Min| differential propagation delay.

### **Test Circuits and Waveforms**

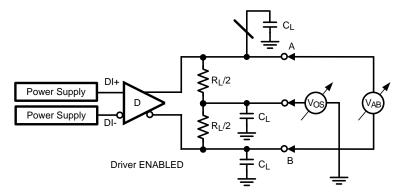


Figure 2. Differential Driver Test Circuit



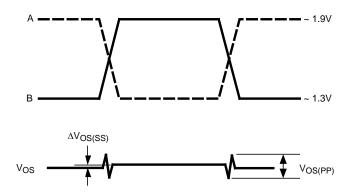


Figure 3. Differential Driver Waveforms

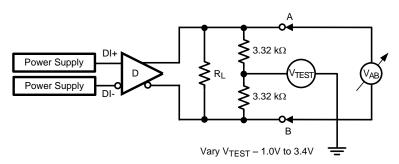


Figure 4. Differential Driver Full Load Test Circuit

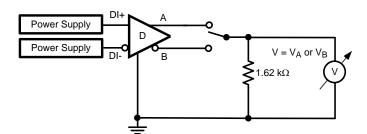


Figure 5. Differential Driver DC Open Test Circuit

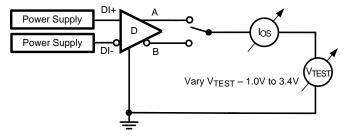


Figure 6. Differential Driver Short-Circuit Test Circuit



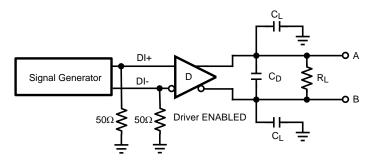


Figure 7. Driver Propagation Delay and Transition Time Test Circuit

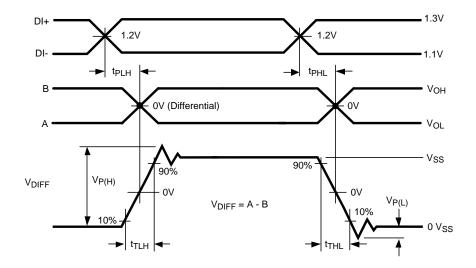


Figure 8. Driver Propagation Delays and Transition Time Waveforms

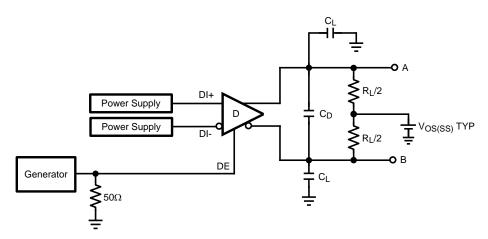


Figure 9. Driver TRI-STATE Delay Test Circuit

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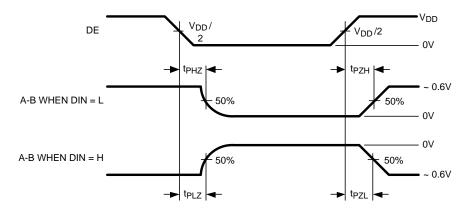


Figure 10. Driver TRI-STATE Delay Waveforms



## **Typical Performance Characteristics**

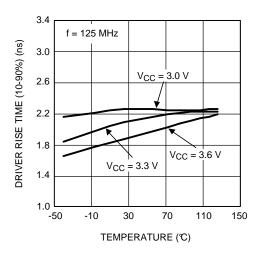


Figure 11. Driver Rise Time as a Function of Temperature

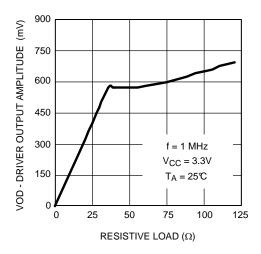


Figure 13. Driver Output Signal Amplitude as a Function of Resistive Load

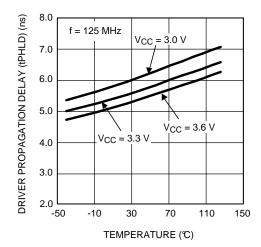


Figure 15. Driver Propagation Delay (tPHLD) as a Function of Temperature

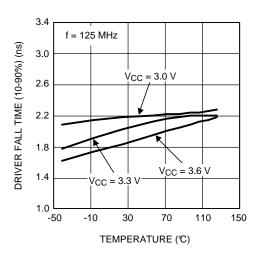


Figure 12. Driver Fall Time as a Function of Temperature

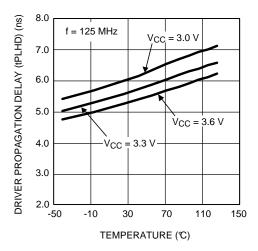


Figure 14. Driver Propagation Delay (tPLHD) as a Function of Temperature

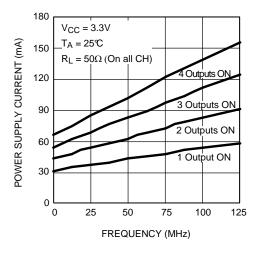


Figure 16. Driver Power Supply Current as a Function of Frequency





31-Jan-2013

#### **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	-		Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Top-Side Markings	Samples
	(1)		Drawing			(2)		(3)		(4)	
DS91M125TMA	ACTIVE	SOIC	D	16		TBD	Call TI	Call TI	-40 to 85		Samples
DS91M125TMA/NOPB	ACTIVE	SOIC	D	16	48	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM		DS91M125 TMA	Samples
DS91M125TMAX/NOPB	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM		DS91M125 TMA	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** Tl's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder humps used between the die and package, or 2) lead-based die adhesive used between

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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<sup>(4)</sup> Only one of markings shown within the brackets will appear on the physical device.

**PACKAGE MATERIALS INFORMATION** 

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# TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
DS91M125TMAX/NOPB	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.3	8.0	16.0	Q1

**PACKAGE MATERIALS INFORMATION** 

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#### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
DS91M125TMAX/NOPB	SOIC	D	16	2500	367.0	367.0	35.0

# D (R-PDS0-G16)

# PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



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